

### Applications

- Bluetooth<sup>tm</sup> wireless technology (Class 1)
- USB dongles
- PCMCIA, flash cards
- Access points
- 2.4GHz cordless telephone

#### Features

- +22.5dBm at 45% Power Added Efficiency
- Low current 80mA typical @ P<sub>OUT</sub> = +20 dBm
- Temperature stability better than 1dB over -40C to +85°C
- Power-control and power-down modes
- 3.3V single supply operation
- Small plastic package: 6 lead LPCC (1.6mm x 3.0mm)

# **Ordering Information**

Туре	Package	Remark
PA2423L	6 Pin LPCC	Samples
PA2423L-R	6 Pin LPCC	Shipped in Tape & Reel
PA2423L-EV	Evaluation Kit	

### **Product Description**

A monolithic, high-efficiency, silicon-germanium power amplifier IC, the PA2423L is designed for 2.4GHz wireless applications, including Bluetooth<sup>TM</sup> Class1 and 2.4GHz cordless telephone applications. It delivers +22.5 dBm output power with 45% power-added efficiency, making it capable of overcoming insertion losses of up to 2.5 dB between amplifier output and antenna input.

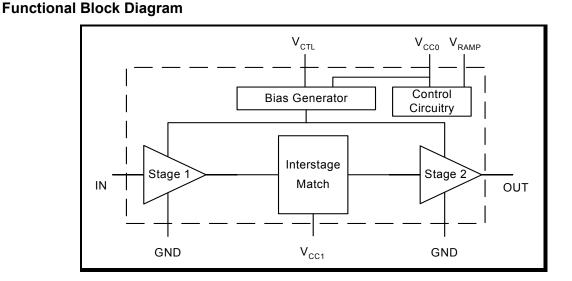
The PA2423L contains an analog control input for improving PAE at reduced output power levels.

The PA2423L provides a digital control input for controlling power up and power down modes of operation.

An on-chip ramping circuit provides the turn-on/off switching of amplifier output with less than 3dB overshoot, meeting the Bluetooth<sup>TM</sup> specification 1.1.

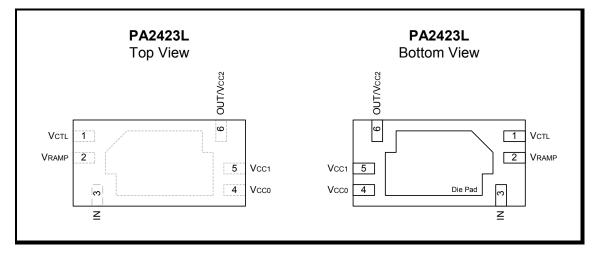
The PA2423L operates at 3.3V DC. At typical output power level (+22.5 dBm), its current consumption is 125 mA.

The silicon/silicon-germanium structure of the PA2423L, and its exposed die-pad package, soldered to the system PCB, provide high thermal conductivity and a subsequently low junction temperature. This device is capable of operating at a duty cycle of 100 percent.





# Pin Out Diagram



# **Pin Out Description**

Pin No.	Name	Description				
1	V <sub>CTL</sub>	Controls the output level of the power amplifier. An analog control signal between 0V and $V_{CC}$ varies the PA output power between minimum and maximum values				
2	V <sub>RAMP</sub>	Power Amplifier Enable pin. A digital control signal with logic high (power up) and logic low (power down) is used to turn the device on and off.				
3	IN	Power amplifier RF input, external input matching network with DC blocking is required				
4	V <sub>CC0</sub>	Bias supply voltage				
5	V <sub>CC1</sub>	Stage 1 collector supply voltage, external inter-stage matching network is required				
6	OUT/V <sub>CC2</sub>	PA Output and Stage2 collector supply voltage, external output matching network with DC blocking is required				
Die Pad	GND	Heatslug Die Pad is ground				



### **Absolute Maximum Ratings**

Operation in excess of any one of above Absolute Maximum Ratings may result in permanent damage. This device is a high performance RF integrated circuit with ESD rating < 600V and is ESD sensitive. Handling and assembly of this device should be at ESD protected workstations.

Symbol	Parameter	Min.	Max.	Unit
V <sub>cc</sub>	Supply Voltage	-0.3	+3.6	V
V <sub>CTL</sub>	Control Voltage	-0.3	V <sub>CC</sub>	V
V <sub>RAMP</sub>	Ramping Voltage	-0.3	V <sub>CC</sub>	V
IN	RF Input Power		+8	dBm
T <sub>A</sub>	Operating Temperature Range	-40	+85	°C
T <sub>STG</sub>	Storage Temperature Range	-40	+150	°C
Tj	Maximum Junction Temperature		+150	°C

# **DC Electrical Characteristics**

Conditions:  $V_{CC0} = V_{CC1} = V_{CC2} = V_{RAMP} = 3.3V$ ,  $V_{CTL} = 3.3V$ ,  $P_{IN} = +2dBm$ ,  $T_A = 25^{\circ}C$ , f = 2.45GHz, input and output externally matched to  $50\Omega$  unless otherwise noted.

Symbol	Parameter	Note	Min.	Тур.	Max.	Unit
V <sub>CC</sub>	Supply Voltage		2.7	3.3	3.6	V
I <sub>cc</sub>	Supply Current (I <sub>CC</sub> = I <sub>VCC0</sub> + I <sub>VCC1</sub> + I <sub>VCC2</sub> ), $V_{CTL} = 3.3V$	1		125	150	mA
ΔIcc <sub>temp</sub>	Supply Current variation over temperature from $T_A = 25^{\circ}C$ (-40°C < $T_A < +85^{\circ}C$ )	3		25		%
V <sub>CTL</sub>	PA Output Power Control Voltage Range		0		V <sub>cc</sub>	V
I <sub>CTL</sub>	Current sunk by V <sub>CTL</sub> pin	1		200	250	μA
V <sub>RAMP</sub>	Logic High Voltage	3	2.0			V
	Logic Low Voltage	3			0.8	V
I <sub>stdby</sub>	Leakage Current when $V_{RAMP} = 0V$ , $V_{CTL} = high$	1		0.5	10	μA



## **AC Electrical Characteristics**

Symbol	Parameter	Note	Min.	Тур.	Max.	Unit	
fL-U	Frequency Range	3	2400		2500	MHz	
Pout	Output Power @ P <sub>IN</sub> =+2 dBm, V <sub>CTL</sub> = 3.3V	1	20	22.5	23.5	dBm	
	Output Power @ $P_{IN}$ =+2 dBm, $V_{CTL}$ = 0.4V	1		-20	0	dBm	
$\Delta P_{temp}$	Output Power variation over temperature (-40°C < $T_A$ <+85°C)	3		1	2	dB	
dP <sub>OUT</sub> /dV <sub>CTL</sub>	Control Voltage Sensitivity	3			120	dBm/V	
PAE	Power Added Efficiency at +22.5 dBm Output Power			45		%	
	Gain @ P <sub>IN</sub> = -22 dBm		25.5	26.5		dB	
G	Gain @ P <sub>IN</sub> = -10 dBm	3	25.0	25.4		dB	
	Gain @ P <sub>IN</sub> = -6 dBm		23.5	24.0		dB	
G <sub>VAR</sub>	Gain Variation over band (2400-2500 MHz)	3		0.7	1.0	dB	
2f,3f,4f,5f	Harmonics	3, 4		-40	-35	dBc	
$IS_{21} \: I_{OFF}$	Isolation in "OFF" State, P <sub>IN</sub> = +2dBm, V <sub>RAMP</sub> = 0V	2	15	20		dB	
IS <sub>12</sub> I	Reverse Isolation	2	32	42		dB	
STAB	Stability (P <sub>IN</sub> = +2dBm, Load VSWR = 6:1)	2	All non-harmonically related outputs less than -50 dBc				

Conditions:  $V_{CC0} = V_{CC1} = V_{CC2} = V_{RAMP} = 3.3V$ ,  $V_{CTL} = 3.3V$ ,  $P_{IN} = +2 \text{ dBm}$ ,  $T_A = 25^{\circ}C$ , f = 2.45 GHz, input and

**Notes:** (1) Guaranteed by production test at  $T_A = 25^{\circ}C$ .

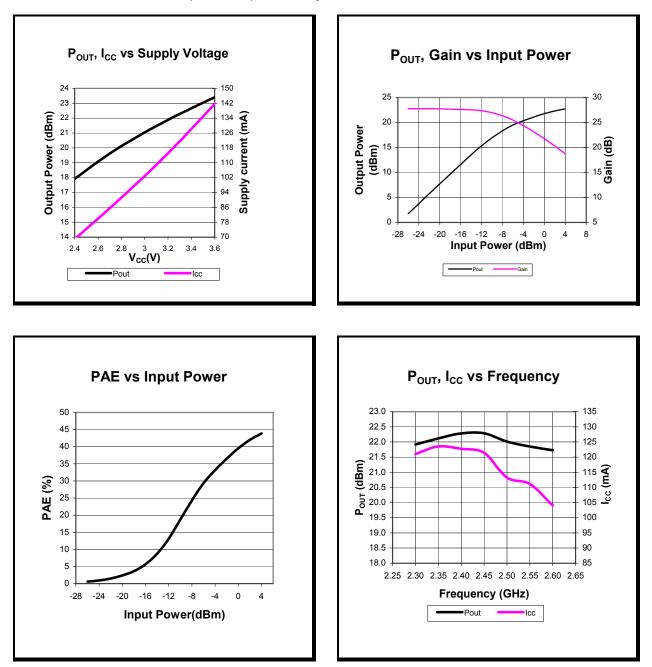
(2) Guaranteed by design only(3) Guaranteed by design and characterization

(4) Harmonic levels are greatly affected by topology of external matching networks.

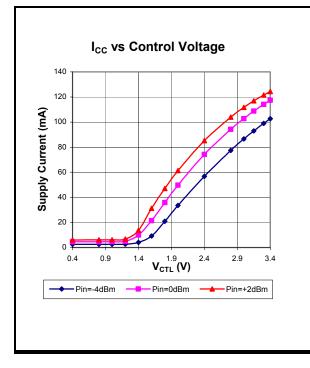


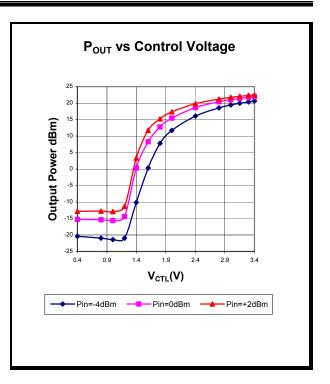
## **Typical Performance Characteristics**

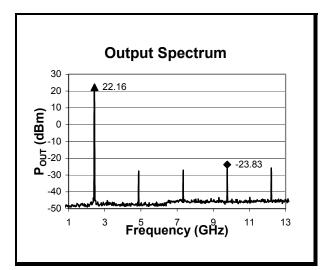
Test Conditions: SiGe PA2423L-EV:  $V_{CC0} = V_{CC1} = V_{CC2} = V_{RAMP} = 3.3V$ ,  $V_{CTL} = 3.3V$ ,  $P_{IN} = +2$  dBm,  $T_A = 25^{\circ}C$ , f = 2.45GHz, input and output externally matched to 50 $\Omega$  unless otherwise noted

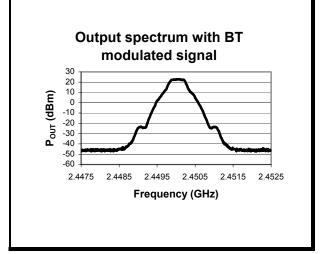








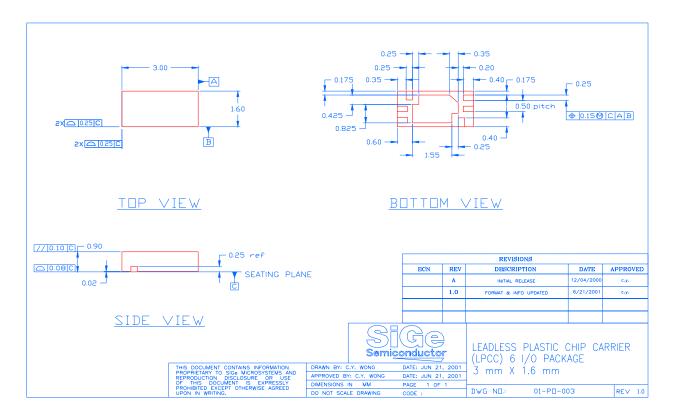






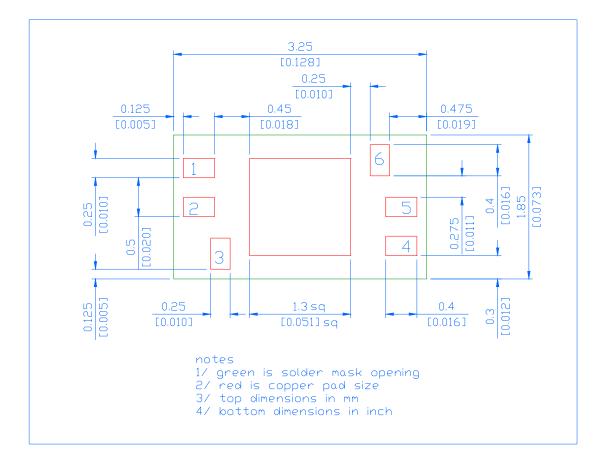
#### **Package Dimensions**

The PA2423L is packaged in a 1.6 mm x 3.0 mm 6 lead LPCC package. The underside of the package is an exposed die-pad structure. This allows for direct soldering to the PCB for enhanced thermal conductivity. The package dimensions are shown in the drawing below.





# LPCC 6 PCB Footprint Layout





#### Applications Information

For test and design purposes, SiGe Semiconductor offers an evaluation board for the PA2423L. The order part number for the evaluation board is PA2423L-EV. The evaluation board is intended to simplify the testing with respect to RF performance of this power amplifier.

The application note, 13-APP-01 provides the supporting information for using the evaluation board. It contains information on the schematic, bill of materials and recommended layout for the power amplifier and the input and output matching networks. To assist in the design process, this layout is available, upon request, in gerber file format.

#### Using V<sub>RAMP</sub>

 $V_{RAMP}$  is a digital pin used to power-up and power-down the PA2423L in Time Duplex systems such as Bluetooth<sup>TM</sup> 1.1. During receive mode,  $V_{RAMP}$  voltage is pulled down, PA2423L acts as a 25 dB isolation block between the radio and the antenna while consuming a modest 1µA. In transmit mode,  $V_{RAMP}$  voltage is pulled to  $V_{CC}$  and PA2423L offers 19dB to 21dB of large signal gain. The rise and fall time are in the order of 1-2µsec.

#### Using V<sub>CTL</sub>

 $V_{CTL}$  is an analog pin that is designed to control the gain of PA2423L. Applying a voltage between 0V and  $V_{CC}$  will adjust the gain between -15dB and 21dB. Used in combination with a variable drive level to PA2423L, the  $V_{CTL}$  function can greatly optimize the PAE of the system at all four Bluetooth<sup>TM</sup> transmitted power levels.

By applying approximately 1.4V to  $V_{CTL}$ , for example, a Class1 radio can be modified to a Class2 radio with the PA2423L consuming only 15mA.

By implementing a resistor DAC, the  $V_{CTL}$  pin can interface with Bluetooth<sup>TM</sup> transceivers offering digital and programmable outputs.



http://www.sige.com

# Headquarters: Canada

Phone: +1 613 820 9244

Fax: +1 613 820 4933

2680 Queensview Drive

Ottawa ON K2B 8J9 Canada

sales@sige.com

San Diego

United Kingdom

1010 Cambourne Business Park Cambourne Cambridge CB3 6DP

Hong Kong

Phone: +1 852 9177 1917

Phone: +1 760 788 5852

Phone: +44 1223 598 444 Fax: +44 1223 598 035

Product Preview

The datasheet contains information from the product concept specification. SiGe Semiconductor reserves the right to change information at any time without notification.

Preliminary Information

The datasheet contains information from the design target specification. SiGe Semiconductor reserves the right to change information at any time without notification.

#### Final

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